



Welcome to [E-XFL.COM](https://www.e-xfl.com)

### Understanding [Embedded - Microprocessors](#)

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

### Applications of [Embedded - Microprocessors](#)

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

#### Details

Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.2GHz
Co-Processors/DSP	Signal Processing; SPE, Security; SEC
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCBGA (29x29)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8547evuatg">https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8547evuatg</a>

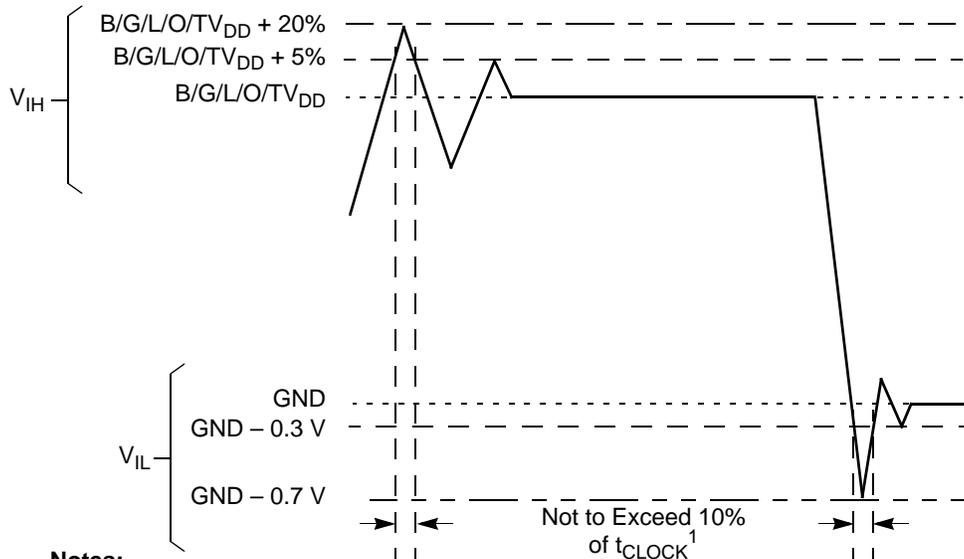
**Table 2. Recommended Operating Conditions (continued)**

Characteristic	Symbol	Recommended Value	Unit	Notes
Junction temperature range	T <sub>j</sub>	0 to 105	°C	—

**Notes:**

1. This voltage is the input to the filter discussed in [Section 22.2, “PLL Power Supply Filtering,”](#) and not necessarily the voltage at the AV<sub>DD</sub> pin, which may be reduced from V<sub>DD</sub> by the filter.
2. **Caution:** MV<sub>IN</sub> must not exceed GV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
3. **Caution:** OV<sub>IN</sub> must not exceed OV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
4. **Caution:** L/TV<sub>IN</sub> must not exceed L/TV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.

The following figure shows the undershoot and overshoot voltages at the interfaces of this device.



**Notes:**

1. t<sub>CLOCK</sub> refers to the clock period associated with the respective interface:  
 For I<sup>2</sup>C and JTAG, t<sub>CLOCK</sub> references SYSCLK.  
 For DDR, t<sub>CLOCK</sub> references MCLK.  
 For eTSEC, t<sub>CLOCK</sub> references EC\_GTX\_CLK125.  
 For LBIU, t<sub>CLOCK</sub> references LCLK.  
 For PCI, t<sub>CLOCK</sub> references PCI<sub>n</sub>\_CLK or SYSCLK.  
 For SerDes, t<sub>CLOCK</sub> references SD\_REF\_CLK.
2. Note that with the PCI overshoot allowed (as specified above), the device does not fully comply with the maximum AC ratings and device protection guideline outlined in the PCI rev. 2.2 standard (section 4.2.2.3).

**Figure 2. Overshoot/Undershoot Voltage for GV<sub>DD</sub>/OV<sub>DD</sub>/LV<sub>DD</sub>/BV<sub>DD</sub>/TV<sub>DD</sub>**

The core voltage must always be provided at nominal 1.1 V. Voltage to the processor interface I/Os are provided through separate sets of supply pins and must be provided at the voltages shown in [Table 2](#). The input voltage threshold scales with respect to the associated I/O supply voltage. OV<sub>DD</sub> and LV<sub>DD</sub> based receivers are simple CMOS I/O circuits and satisfy appropriate LVCMOS type specifications. The DDR SDRAM interface uses a single-ended differential receiver referenced the externally supplied MV<sub>REF</sub> signal (nominally set to GV<sub>DD</sub>/2) as is appropriate for the SSTL2 electrical signaling standard.

### 3 Power Characteristics

The estimated typical power dissipation for the core complex bus (CCB) versus the core frequency for this family of PowerQUICC III devices is shown in the following table.

**Table 4. Device Power Dissipation**

CCB Frequency <sup>1</sup>	Core Frequency	SLEEP <sup>2</sup>	Typical-65 <sup>3</sup>	Typical-105 <sup>4</sup>	Maximum <sup>5</sup>	Unit
400	800	2.7	4.6	7.5	8.1	W
	1000	2.7	5.0	7.9	8.5	W
	1200	2.7	5.4	8.3	8.9	
500	1500	11.5	13.6	16.5	18.6	W
533	1333	6.2	7.9	10.8	12.8	W

**Notes:**

1. CCB frequency is the SoC platform frequency, which corresponds to the DDR data rate.
2. SLEEP is based on  $V_{DD} = 1.1\text{ V}$ ,  $T_j = 65^\circ\text{C}$ .
3. Typical-65 is based on  $V_{DD} = 1.1\text{ V}$ ,  $T_j = 65^\circ\text{C}$ , running Dhrystone.
4. Typical-105 is based on  $V_{DD} = 1.1\text{ V}$ ,  $T_j = 105^\circ\text{C}$ , running Dhrystone.
5. Maximum is based on  $V_{DD} = 1.1\text{ V}$ ,  $T_j = 105^\circ\text{C}$ , running a smoke test.

Figure 4 shows the DDR SDRAM output timing diagram.+

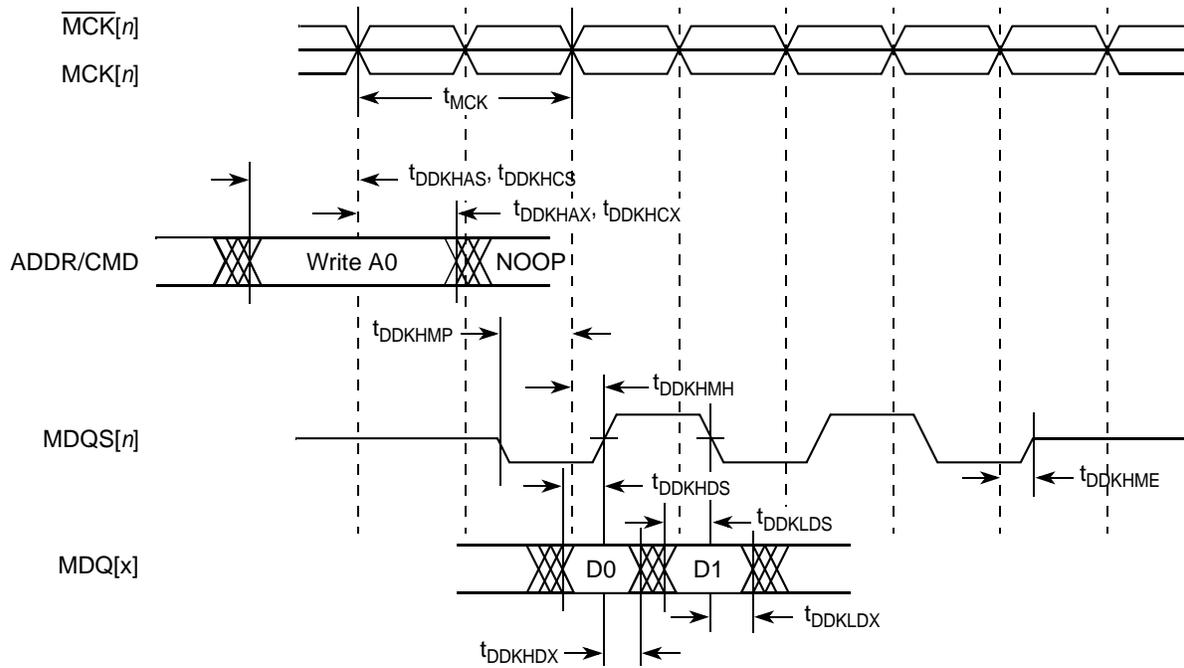


Figure 4. DDR SDRAM Output Timing Diagram

Figure 5 provides the AC test load for the DDR bus.

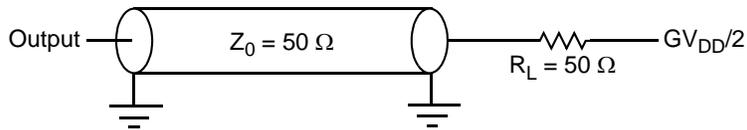


Figure 5. DDR AC Test Load

Table 42. Local Bus Timing Parameters—PLL Bypassed (continued)

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
LGTA/LUPWAIT input hold from local bus clock	$t_{LBIXKL2}$	-1.3	—	ns	4, 5
LALE output transition to LAD/LDP output transition (LATCH hold time)	$t_{LBOTOT}$	1.5	—	ns	6
Local bus clock to output valid (except LAD/LDP and LALE)	$t_{LBKLOV1}$	—	-0.3	ns	—
Local bus clock to data valid for LAD/LDP	$t_{LBKLOV2}$	—	-0.1	ns	4
Local bus clock to address valid for LAD	$t_{LBKLOV3}$	—	0	ns	4
Local bus clock to LALE assertion	$t_{LBKLOV4}$	—	0	ns	4
Output hold from local bus clock (except LAD/LDP and LALE)	$t_{LBKLOX1}$	-3.7	—	ns	4
Output hold from local bus clock for LAD/LDP	$t_{LBKLOX2}$	-3.7	—	ns	4
Local bus clock to output high Impedance (except LAD/LDP and LALE)	$t_{LBKLOZ1}$	—	0.2	ns	7
Local bus clock to output high impedance for LAD/LDP	$t_{LBKLOZ2}$	—	0.2	ns	7

**Notes:**

1. The symbols used for timing specifications follow the pattern of  $t_{(\text{first two letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$  for inputs and  $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$  for outputs. For example,  $t_{LBIXKH1}$  symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the  $t_{LBK}$  clock reference (K) goes high (H), in this case for clock one (1). Also,  $t_{LBKHGX}$  symbolizes local bus timing (LB) for the  $t_{LBK}$  clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
2. All timings are in reference to local bus clock for PLL bypass mode. Timings may be negative with respect to the local bus clock because the actual launch and capture of signals is done with the internal launch/capture clock, which precedes LCLK by  $t_{LBKHK1}$ .
3. Maximum possible clock skew between a clock LCLK[m] and a relative clock LCLK[n]. Skew measured between complementary signals at  $BV_{DD}/2$ .
4. All signals are measured from  $BV_{DD}/2$  of the rising edge of local bus clock for PLL bypass mode to  $0.4 \times BV_{DD}$  of the signal in question for 3.3-V signaling levels.
5. Input timings are measured at the pin.
6. The value of  $t_{LBOTOT}$  is the measurement of the minimum time between the negation of LALE and any change in LAD.
7. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
8. Guaranteed by characterization.
9. Guaranteed by design.

Table 53. PCI-X AC Timing Specifications at 66 MHz (continued)

Parameter	Symbol	Min	Max	Unit	Notes
$\overline{\text{HRESET}}$ to PCI-X initialization pattern hold time	$t_{\text{PCRHX}}$	0	50	ns	6, 11

**Notes:**

1. See the timing measurement conditions in the *PCI-X 1.0a Specification*.
2. Minimum times are measured at the package pin (not the test point). Maximum times are measured with the test point and load circuit.
3. Setup time for point-to-point signals applies to  $\overline{\text{REQ}}$  and  $\overline{\text{GNT}}$  only. All other signals are bused.
4. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
5. Setup time applies only when the device is not driving the pin. Devices cannot drive and receive signals at the same time.
6. Maximum value is also limited by delay to the first transaction (time for  $\overline{\text{HRESET}}$  high to first configuration access,  $t_{\text{PCRHFV}}$ ). The PCI-X initialization pattern control signals after the rising edge of  $\overline{\text{HRESET}}$  must be negated no later than two clocks before the first  $\overline{\text{FRAME}}$  and must be floated no later than one clock before  $\overline{\text{FRAME}}$  is asserted.
7. A PCI-X device is permitted to have the minimum values shown for  $t_{\text{PCKHOV}}$  and  $t_{\text{CYC}}$  only in PCI-X mode. In conventional mode, the device must meet the requirements specified in PCI 2.2 for the appropriate clock frequency.
8. Device must meet this specification independent of how many outputs switch simultaneously.
9. The timing parameter  $t_{\text{PCRHFV}}$  is a minimum of 10 clocks rather than the minimum of 5 clocks in the *PCI-X 1.0a Specification*.
10. Guaranteed by characterization.
11. Guaranteed by design.

This table provides the PCI-X AC timing specifications at 133 MHz. Note that the maximum PCI-X frequency in synchronous mode is 110 MHz.

Table 54. PCI-X AC Timing Specifications at 133 MHz

Parameter	Symbol	Min	Max	Unit	Notes
SYSCLK to signal valid delay	$t_{\text{PCKHOV}}$	—	3.8	ns	1, 2, 3, 7, 8
Output hold from SYSCLK	$t_{\text{PCKHOX}}$	0.7	—	ns	1, 11
SYSCLK to output high impedance	$t_{\text{PCKHOZ}}$	—	7	ns	1, 4, 8, 12
Input setup time to SYSCLK	$t_{\text{PCIVKH}}$	1.2	—	ns	3, 5, 9, 11
Input hold time from SYSCLK	$t_{\text{PCIXKH}}$	0.5	—	ns	11
$\overline{\text{REQ64}}$ to $\overline{\text{HRESET}}$ setup time	$t_{\text{PCRVRH}}$	10	—	clocks	12
$\overline{\text{HRESET}}$ to $\overline{\text{REQ64}}$ hold time	$t_{\text{PCRHRX}}$	0	50	ns	12
$\overline{\text{HRESET}}$ high to first $\overline{\text{FRAME}}$ assertion	$t_{\text{PCRHFV}}$	10	—	clocks	10, 12
PCI-X initialization pattern to $\overline{\text{HRESET}}$ setup time	$t_{\text{PCIVRH}}$	10	—	clocks	12

## 16.2.4 AC Requirements for SerDes Reference Clocks

The clock driver selected must provide a high quality reference clock with low phase noise and cycle-to-cycle jitter. Phase noise less than 100 kHz can be tracked by the PLL and data recovery loops and is less of a problem. Phase noise above 15 MHz is filtered by the PLL. The most problematic phase noise occurs in the 1–15 MHz range. The source impedance of the clock driver must be  $50\ \Omega$  to match the transmission line and reduce reflections which are a source of noise to the system.

The detailed AC requirements of the SerDes reference clocks are defined by each interface protocol based on application usage. See the following sections for detailed information:

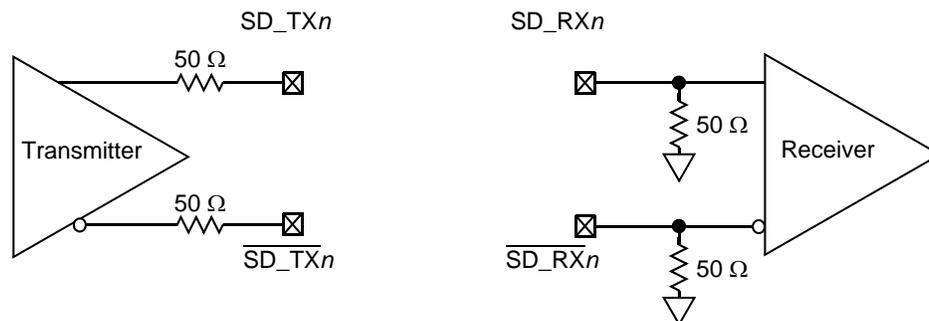
- [Section 17.2, “AC Requirements for PCI Express SerDes Clocks”](#)
- [Section 18.2, “AC Requirements for Serial RapidIO SD\\_REF\\_CLK and SD\\_REF\\_CLK”](#)

### 16.2.4.1 Spread Spectrum Clock

SD\_REF\_CLK/SD\_REF\_CLK are designed to work with a spread spectrum clock (+0% to –0.5% spreading at 30–33 kHz rate is allowed), assuming both ends have same reference clock. For better results, a source without significant unintended modulation must be used.

## 16.3 SerDes Transmitter and Receiver Reference Circuits

Figure 47 shows the reference circuits for SerDes data lane’s transmitter and receiver.



**Figure 47. SerDes Transmitter and Receiver Reference Circuits**

The DC and AC specification of SerDes data lanes are defined in each interface protocol section below (PCI Express, Serial Rapid IO, or SGMII) in this document based on the application usage:

- [Section 17, “PCI Express”](#)
- [Section 18, “Serial RapidIO”](#)

Note that external an AC coupling capacitor is required for the above three serial transmission protocols with the capacitor value defined in the specification of each protocol section.

Table 56. Differential Transmitter (TX) Output Specifications (continued)

Symbol	Parameter	Min	Nom	Max	Unit	Comments
$V_{TX-DC-CM}$	The TX DC common mode voltage	0	—	3.6	V	The allowed DC common mode voltage under any conditions. See Note 6.
$I_{TX-SHORT}$	TX short circuit current limit	—	—	90	mA	The total current the transmitter can provide when shorted to its ground
$T_{TX-IDLE-MIN}$	Minimum time spent in electrical idle	50	—		UI	Minimum time a transmitter must be in electrical idle utilized by the receiver to start looking for an electrical idle exit after successfully receiving an electrical idle ordered set
$T_{TX-IDLE-SET-TO-IDLE}$	Maximum time to transition to a valid electrical idle after sending an electrical idle ordered set	—	—	20	UI	After sending an electrical idle ordered set, the transmitter must meet all electrical idle specifications within this time. This is considered a debounce time for the transmitter to meet electrical idle after transitioning from L0.
$T_{TX-IDLE-TO-DIFF-DATA}$	Maximum time to transition to valid TX specifications after leaving an electrical idle condition	—	—	20	UI	Maximum time to meet all TX specifications when transitioning from electrical idle to sending differential data. This is considered a debounce time for the TX to meet all TX specifications after leaving electrical idle
$RL_{TX-DIFF}$	Differential return loss	12	—	—	dB	Measured over 50 MHz to 1.25 GHz. See Note 4.
$RL_{TX-CM}$	Common mode return loss	6	—	—	dB	Measured over 50 MHz to 1.25 GHz. See Note 4.
$Z_{TX-DIFF-DC}$	DC differential TX impedance	80	100	120	$\Omega$	TX DC differential mode low impedance
$Z_{TX-DC}$	Transmitter DC impedance	40	—	—	$\Omega$	Required TX D+ as well as D– DC impedance during all states
$L_{TX-SKEW}$	Lane-to-lane output skew	—	—	500 + 2 UI	ps	Static skew between any two transmitter lanes within a single Link
$C_{TX}$	AC coupling capacitor	75	—	200	nF	All transmitters shall be AC coupled. The AC coupling is required either within the media or within the transmitting component itself. See note 8.

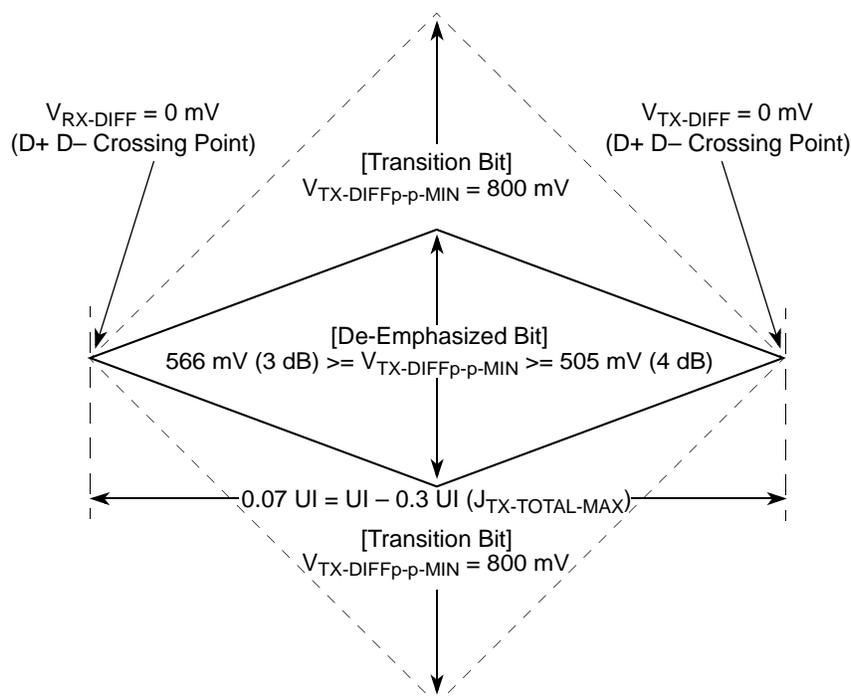


Figure 48. Minimum Transmitter Timing and Voltage Output Compliance Specifications

### 17.4.3 Differential Receiver (RX) Input Specifications

Table 57 defines the specifications for the differential input at all receivers (RXs). The parameters are specified at the component pins.

Table 57. Differential Receiver (RX) Input Specifications

Symbol	Parameter	Min	Nom	Max	Unit	Comments
UI	Unit interval	399.88	400	400.12	ps	Each UI is 400 ps $\pm$ 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1.
$V_{RX-DIFFp-p}$	Differential peak-to-peak input voltage	0.175	—	1.200	V	$V_{RX-DIFFp-p} = 2 \times  V_{RX-D+} - V_{RX-D-} $ . See Note 2.
$T_{RX-EYE}$	Minimum receiver eye width	0.4	—	—	UI	The maximum interconnect media and transmitter jitter that can be tolerated by the receiver can be derived as $T_{RX-MAX-JITTER} = 1 - T_{RX-EYE} = 0.6$ UI. See Notes 2 and 3.
$T_{RX-EYE-MEDIAN-to-MAX-JITTER}$	Maximum time between the jitter median and maximum deviation from the median	—	—	0.3	UI	Jitter is defined as the measurement variation of the crossing points ( $V_{RX-DIFFp-p} = 0$ V) in relation to a recovered TX UI. A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI. See Notes 2, 3, and 7.

Table 57. Differential Receiver (RX) Input Specifications (continued)

Symbol	Parameter	Min	Nom	Max	Unit	Comments
$L_{TX-SKEW}$	Total Skew	—	—	20	ns	Skew across all lanes on a Link. This includes variation in the length of SKP ordered set (for example, COM and one to five symbols) at the RX as well as any delay differences arising from the interconnect itself.

**Notes:**

1. No test load is necessarily associated with this value.
2. Specified at the measurement point and measured over any 250 consecutive UIs. The test load in [Figure 50](#) must be used as the RX device when taking measurements (also see the receiver compliance eye diagram shown in [Figure 49](#)). If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as a reference for the eye diagram.
3. A  $T_{RX-EYE} = 0.40$  UI provides for a total sum of 0.60 UI deterministic and random jitter budget for the transmitter and interconnect collected any 250 consecutive UIs. The  $T_{RX-EYE-MEDIAN-to-MAX-JITTER}$  specification ensures a jitter distribution in which the median and the maximum deviation from the median is less than half of the total. UI jitter budget collected over any 250 consecutive TX UIs. Note that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value. If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as the reference for the eye diagram.
4. The receiver input impedance shall result in a differential return loss greater than or equal to 15 dB with the D+ line biased to 300 mV and the D– line biased to –300 mV and a common mode return loss greater than or equal to 6 dB (no bias required) over a frequency range of 50 MHz to 1.25 GHz. This input impedance requirement applies to all valid input levels. The reference impedance for return loss measurements for is 50  $\Omega$  to ground for both the D+ and D– line (that is, as measured by a vector network analyzer with 50- $\Omega$  probes—see [Figure 50](#)). Note: that the series capacitors CTX is optional for the return loss measurement.
5. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM) there is a 5 ms transition time before receiver termination values must be met on all unconfigured lanes of a port.
6. The RX DC common mode Impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the RX ground.
7. It is recommended that the recovered TX UI is calculated using all edges in the 3500 consecutive UI interval with a fit algorithm using a minimization merit function. Least squares and median deviation fits have worked well with experimental and simulated data.

## 17.5 Receiver Compliance Eye Diagrams

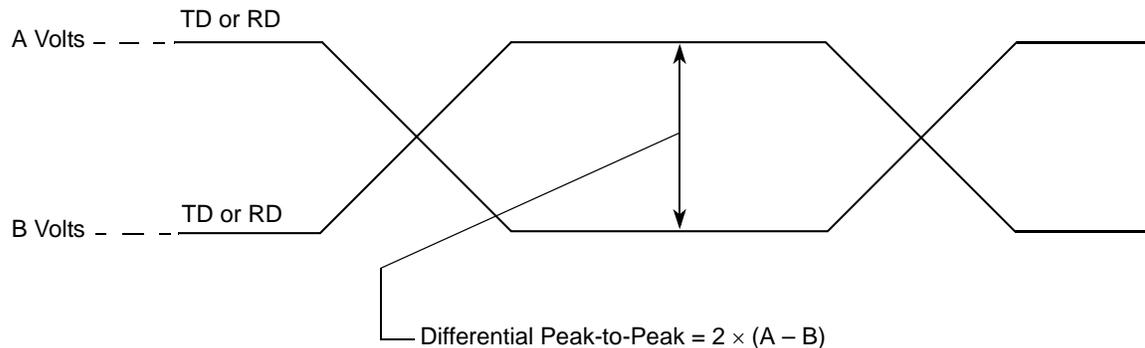
The RX eye diagram in [Figure 49](#) is specified using the passive compliance/test measurement load (see [Figure 50](#)) in place of any real PCI Express RX component.

Note: In general, the minimum receiver eye diagram measured with the compliance/test measurement load (see [Figure 50](#)) is larger than the minimum receiver eye diagram measured over a range of systems at the input receiver of any real PCI Express component. The degraded eye diagram at the input receiver is due to traces internal to the package as well as silicon parasitic characteristics which cause the real PCI Express component to vary in impedance from the compliance/test measurement load. The input receiver eye diagram is implementation specific and is not specified. RX component designer must provide additional margin to adequately compensate for the degraded minimum receiver eye diagram (shown in [Figure 49](#)) expected at the input receiver based on some adequate combination of system simulations and the return loss measured looking into the RX package and silicon. The RX eye diagram must be aligned in time using the jitter median to locate the center of the eye diagram.

## 18.3 Signal Definitions

LP-serial links use differential signaling. This section defines terms used in the description and specification of differential signals. Figure 51 shows how the signals are defined. The figures show waveforms for either a transmitter output (TD and  $\overline{\text{TD}}$ ) or a receiver input (RD and  $\overline{\text{RD}}$ ). Each signal swings between A volts and B volts where  $A > B$ . Using these waveforms, the definitions are as follows:

1. The transmitter output signals and the receiver input signals TD,  $\overline{\text{TD}}$ , RD, and  $\overline{\text{RD}}$  each have a peak-to-peak swing of  $A - B$  volts.
2. The differential output signal of the transmitter,  $V_{\text{OD}}$ , is defined as  $V_{\text{TD}} - V_{\overline{\text{TD}}}$ .
3. The differential input signal of the receiver,  $V_{\text{ID}}$ , is defined as  $V_{\text{RD}} - V_{\overline{\text{RD}}}$ .
4. The differential output signal of the transmitter and the differential input signal of the receiver each range from  $A - B$  to  $-(A - B)$  volts.
5. The peak value of the differential transmitter output signal and the differential receiver input signal is  $A - B$  volts.
6. The peak-to-peak value of the differential transmitter output signal and the differential receiver input signal is  $2 \times (A - B)$  volts.



**Figure 51. Differential Peak-Peak Voltage of Transmitter or Receiver**

To illustrate these definitions using real values, consider the case of a CML (current mode logic) transmitter that has a common mode voltage of 2.25 V and each of its outputs, TD and  $\overline{\text{TD}}$ , has a swing that goes between 2.5 and 2.0 V. Using these values, the peak-to-peak voltage swing of the signals TD and  $\overline{\text{TD}}$  is 500 mVp-p. The differential output signal ranges between 500 and  $-500$  mV. The peak differential voltage is 500 mV. The peak-to-peak differential voltage is 1000 mVp-p.

## 18.4 Equalization

With the use of high-speed serial links, the interconnect media causes degradation of the signal at the receiver. Effects such as inter-symbol interference (ISI) or data dependent jitter are produced. This loss can be large enough to degrade the eye opening at the receiver beyond what is allowed in the specification. To negate a portion of these effects, equalization can be used. The most common equalization techniques that can be used are:

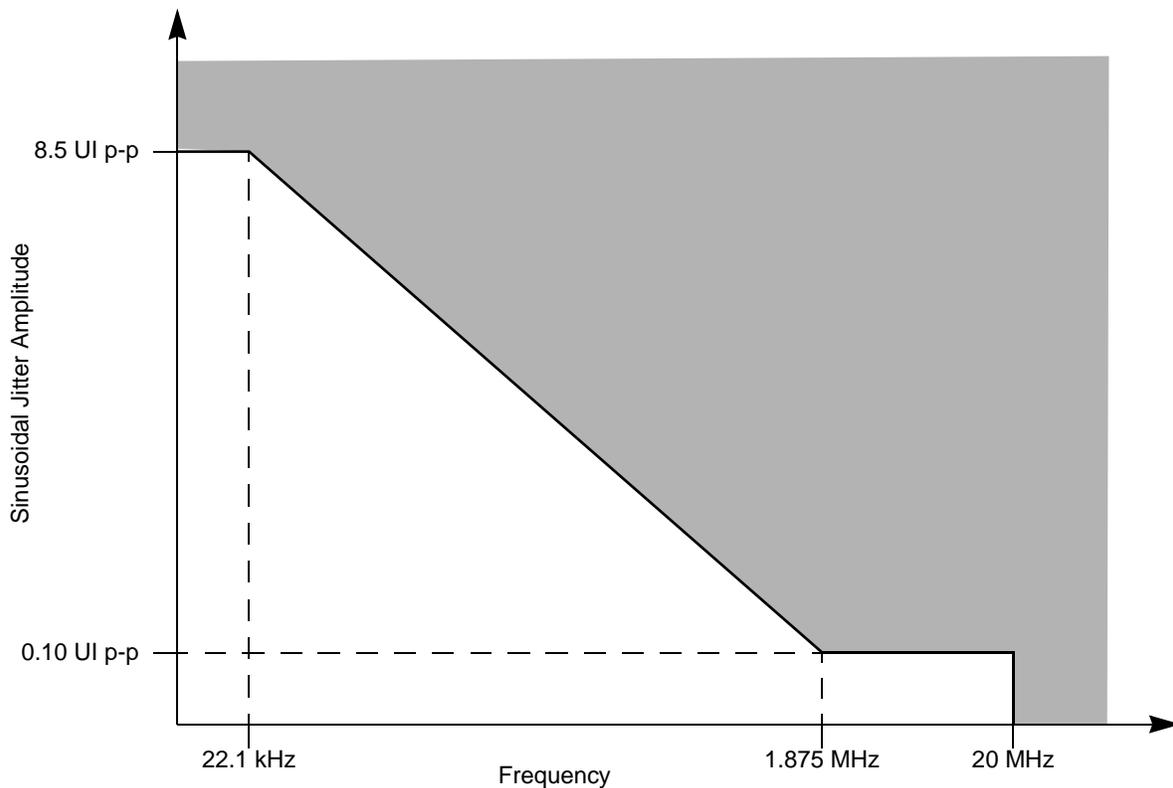
- A passive high pass filter network placed at the receiver. This is often referred to as passive equalization.
- The use of active circuits in the receiver. This is often referred to as adaptive equalization.

**Table 68. Receiver AC Timing Specifications—3.125 GBaud**

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Differential input voltage	$V_{IN}$	200	1600	mVp-p	Measured at receiver
Deterministic jitter tolerance	$J_D$	0.37	—	UI p-p	Measured at receiver
Combined deterministic and random jitter tolerance	$J_{DR}$	0.55	—	UI p-p	Measured at receiver
Total jitter tolerance <sup>1</sup>	$J_T$	0.65	—	UI p-p	Measured at receiver
Multiple input skew	$S_{MI}$	—	22	ns	Skew at the receiver input between lanes of a multilane link
Bit error rate	BER	—	$10^{-12}$		—
Unit interval	UI	320	320	ps	$\pm 100$ ppm

**Note:**

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 53. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.



**Figure 53. Single Frequency Sinusoidal Jitter Limits**



Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
$\overline{\text{MWE}}$	E7	O	$\text{GV}_{\text{DD}}$	—
$\overline{\text{MCAS}}$	H7	O	$\text{GV}_{\text{DD}}$	—
$\overline{\text{MRAS}}$	L8	O	$\text{GV}_{\text{DD}}$	—
MCKE[0:3]	F10, C10, J11, H11	O	$\text{GV}_{\text{DD}}$	11
$\overline{\text{MCS}}$ [0:3]	K8, J8, G8, F8	O	$\text{GV}_{\text{DD}}$	—
MCK[0:5]	H9, B15, G2, M9, A14, F1	O	$\text{GV}_{\text{DD}}$	—
$\overline{\text{MCK}}$ [0:5]	J9, A15, G1, L9, B14, F2	O	$\text{GV}_{\text{DD}}$	—
MODT[0:3]	E6, K6, L7, M7	O	$\text{GV}_{\text{DD}}$	—
MDIC[0:1]	A19, B19	I/O	$\text{GV}_{\text{DD}}$	36
<b>Local Bus Controller Interface</b>				
LAD[0:31]	E27, B20, H19, F25, A20, C19, E28, J23, A25, K22, B28, D27, D19, J22, K20, D28, D25, B25, E22, F22, F21, C25, C22, B23, F20, A23, A22, E19, A21, D21, F19, B21	I/O	$\text{BV}_{\text{DD}}$	—
LDP[0:3]	K21, C28, B26, B22	I/O	$\text{BV}_{\text{DD}}$	—
LA[27]	H21	O	$\text{BV}_{\text{DD}}$	5, 9
LA[28:31]	H20, A27, D26, A28	O	$\text{BV}_{\text{DD}}$	5, 7, 9
$\overline{\text{LCS}}$ [0:4]	J25, C20, J24, G26, A26	O	$\text{BV}_{\text{DD}}$	
$\overline{\text{LCS5/DMA\_DREQ2}}$	D23	I/O	$\text{BV}_{\text{DD}}$	1
$\overline{\text{LCS6/DMA\_DACK2}}$	G20	O	$\text{BV}_{\text{DD}}$	1
$\overline{\text{LCS7/DMA\_DDONE2}}$	E21	O	$\text{BV}_{\text{DD}}$	1
$\overline{\text{LWE0/LBS0/LSDDQM}}[0]$	G25	O	$\text{BV}_{\text{DD}}$	5, 9
$\overline{\text{LWE1/LBS1/LSDDQM}}[1]$	C23	O	$\text{BV}_{\text{DD}}$	5, 9
$\overline{\text{LWE2/LBS2/LSDDQM}}[2]$	J21	O	$\text{BV}_{\text{DD}}$	5, 9
$\overline{\text{LWE3/LBS3/LSDDQM}}[3]$	A24	O	$\text{BV}_{\text{DD}}$	5, 9
LALE	H24	O	$\text{BV}_{\text{DD}}$	5, 8, 9
LBCTL	G27	O	$\text{BV}_{\text{DD}}$	5, 8, 9
LGPL0/LSDA10	F23	O	$\text{BV}_{\text{DD}}$	5, 9
LGPL1/ $\overline{\text{LSDWE}}$	G22	O	$\text{BV}_{\text{DD}}$	5, 9
LGPL2/ $\overline{\text{LOE/LSDRAS}}$	B27	O	$\text{BV}_{\text{DD}}$	5, 8, 9
LGPL3/ $\overline{\text{LSDCAS}}$	F24	O	$\text{BV}_{\text{DD}}$	5, 9
LGPL4/ $\overline{\text{LGT\AA/LUPWAIT/LPBSE}}$	H23	I/O	$\text{BV}_{\text{DD}}$	—
LGPL5	E26	O	$\text{BV}_{\text{DD}}$	5, 9
LCKE	E24	O	$\text{BV}_{\text{DD}}$	—
LCLK[0:2]	E23, D24, H22	O	$\text{BV}_{\text{DD}}$	—

Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
LV <sub>DD</sub>	N8, R7, T9, U6	Power for TSEC1 and TSEC2 (2.5 V, 3.3 V)	LV <sub>DD</sub>	—
TV <sub>DD</sub>	W9, Y6	Power for TSEC3 and TSEC4 (2.5 V, 3.3 V)	TV <sub>DD</sub>	—
GV <sub>DD</sub>	B3, B11, C7, C9, C14, C17, D4, D6, D10, D15, E2, E8, E11, E18, F5, F12, F16, G3, G7, G9, G11, H5, H12, H15, H17, J10, K3, K12, K16, K18, L6, M4, M8, M13	Power for DDR1 and DDR2 DRAM I/O voltage (1.8 V, 2.5)	GV <sub>DD</sub>	—
BV <sub>DD</sub>	C21, C24, C27, E20, E25, G19, G23, H26, J20	Power for local bus (1.8 V, 2.5 V, 3.3 V)	BV <sub>DD</sub>	—
V <sub>DD</sub>	M19, N12, N14, N16, N18, P11, P13, P15, P17, P19, R12, R14, R16, R18, T11, T13, T15, T17, T19, U12, U14, U16, U18, V17, V19	Power for core (1.1 V)	V <sub>DD</sub>	—
SV <sub>DD</sub>	L25, L27, M24, N28, P24, P26, R24, R27, T25, V24, V26, W24, W27, Y25, AA28, AC27	Core Power for SerDes transceivers (1.1 V)	SV <sub>DD</sub>	—
XV <sub>DD</sub>	L20, L22, N23, P21, R22, T20, U23, V21, W22, Y20	Pad Power for SerDes transceivers (1.1 V)	XV <sub>DD</sub>	—
AVDD_LBIU	J28	Power for local bus PLL (1.1 V)	—	26
AVDD_PCI1	AH21	Power for PCI1 PLL (1.1 V)	—	26
AVDD_PCI2	AH22	Power for PCI2 PLL (1.1 V)	—	26
AVDD_CORE	AH15	Power for e500 PLL (1.1 V)	—	26
AVDD_PLAT	AH19	Power for CCB PLL (1.1 V)	—	26
AVDD_SRDS	U25	Power for SRDSPLL (1.1 V)	—	26
SENSEVDD	M14	O	V <sub>DD</sub>	13

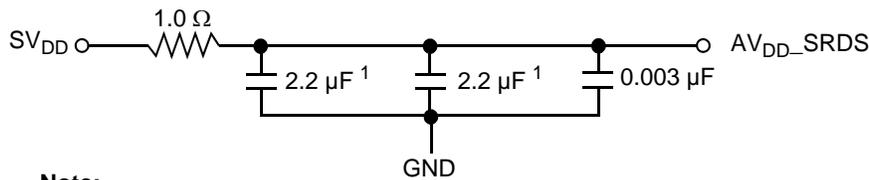
Table 72. MPC8547E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
Reserved	U20, V22, W20, Y22	—	—	15
Reserved	U21, V23, W21, Y23	—	—	15
SD_PLL_TPD	U28	O	XV <sub>DD</sub>	24
SD_REF_CLK	T28	I	XV <sub>DD</sub>	—
$\overline{\text{SD\_REF\_CLK}}$	T27	I	XV <sub>DD</sub>	—
Reserved	AC1, AC3	—	—	2
Reserved	M26, V28	—	—	32
Reserved	M25, V27	—	—	34
Reserved	M20, M21, T22, T23	—	—	38
<b>General-Purpose Output</b>				
GPOUT[24:31]	K26, K25, H27, G28, H25, J26, K24, K23	O	BV <sub>DD</sub>	—
<b>System Control</b>				
$\overline{\text{HRESET}}$	AG17	I	OV <sub>DD</sub>	—
$\overline{\text{HRESET\_REQ}}$	AG16	O	OV <sub>DD</sub>	29
$\overline{\text{SRESET}}$	AG20	I	OV <sub>DD</sub>	—
$\overline{\text{CKSTP\_IN}}$	AA9	I	OV <sub>DD</sub>	—
$\overline{\text{CKSTP\_OUT}}$	AA8	O	OV <sub>DD</sub>	2, 4
<b>Debug</b>				
TRIG_IN	AB2	I	OV <sub>DD</sub>	—
TRIG_OUT/READY/QUIESCE	AB1	O	OV <sub>DD</sub>	6, 9, 19, 29
MSRCID[0:1]	AE4, AG2	O	OV <sub>DD</sub>	5, 6, 9
MSRCID[2:4]	AF3, AF1, AF2	O	OV <sub>DD</sub>	6, 19, 29
MDVAL	AE5	O	OV <sub>DD</sub>	6
CLK_OUT	AE21	O	OV <sub>DD</sub>	11
<b>Clock</b>				
RTC	AF16	I	OV <sub>DD</sub>	—
SYSCLK	AH17	I	OV <sub>DD</sub>	—
<b>JTAG</b>				
TCK	AG28	I	OV <sub>DD</sub>	—
TDI	AH28	I	OV <sub>DD</sub>	12
TDO	AF28	O	OV <sub>DD</sub>	—
TMS	AH27	I	OV <sub>DD</sub>	12
$\overline{\text{TRST}}$	AH23	I	OV <sub>DD</sub>	12

Table 73. MPC8545E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
TDO	AF28	O	OV <sub>DD</sub>	—
TMS	AH27	I	OV <sub>DD</sub>	12
$\overline{\text{TRST}}$	AH23	I	OV <sub>DD</sub>	12
<b>DFT</b>				
L1_TSTCLK	AC25	I	OV <sub>DD</sub>	25
L2_TSTCLK	AE22	I	OV <sub>DD</sub>	25
$\overline{\text{LSSD\_MODE}}$	AH20	I	OV <sub>DD</sub>	25
$\overline{\text{TEST\_SEL}}$	AH14	I	OV <sub>DD</sub>	25
<b>Thermal Management</b>				
THERM0	AG1	—	—	14
THERM1	AH1	—	—	14
<b>Power Management</b>				
ASLEEP	AH18	O	OV <sub>DD</sub>	9, 19, 29
<b>Power and Ground Signals</b>				
GND	A11, B7, B24, C1, C3, C5, C12, C15, C26, D8, D11, D16, D20, D22, E1, E5, E9, E12, E15, E17, F4, F26, G12, G15, G18, G21, G24, H2, H6, H8, H28, J4, J12, J15, J17, J27, K7, K9, K11, K27, L3, L5, L12, L16, N11, N13, N15, N17, N19, P4, P9, P12, P14, P16, P18, R11, R13, R15, R17, R19, T4, T12, T14, T16, T18, U8, U11, U13, U15, U17, U19, V4, V12, V18, W6, W19, Y4, Y9, Y11, Y19, AA6, AA14, AA17, AA22, AA23, AB4, AC2, AC11, AC19, AC26, AD5, AD9, AD22, AE3, AE14, AF6, AF10, AF13, AG8, AG27, K28, L24, L26, N24, N27, P25, R28, T24, T26, U24, V25, W28, Y24, Y26, AA24, AA27, AB25, AC28, L21, L23, N22, P20, R23, T21, U22, V20, W23, Y21, U27	—	—	—
OV <sub>DD</sub>	V16, W11, W14, Y18, AA13, AA21, AB11, AB17, AB24, AC4, AC9, AC21, AD6, AD13, AD17, AD19, AE10, AE8, AE24, AF4, AF12, AF22, AF27, AG26	Power for PCI and other standards (3.3 V)	OV <sub>DD</sub>	—
LV <sub>DD</sub>	N8, R7, T9, U6	Power for TSEC1 and TSEC2 (2.5 V, 3.3 V)	LV <sub>DD</sub>	—
TV <sub>DD</sub>	W9, Y6	Power for TSEC3 and TSEC4 (2.5 V, 3.3 V)	TV <sub>DD</sub>	—

the ground plane. Use ceramic chip capacitors with the highest possible self-resonant frequency. All traces must be kept short, wide and direct.

**Note:**

1. An 0805 sized capacitor is recommended for system initial bring-up.

**Figure 60. SerDes PLL Power Supply Filter**

Note the following:

- $AV_{DD\_SRDS}$  must be a filtered version of  $SV_{DD}$ .
- Signals on the SerDes interface are fed from the  $XV_{DD}$  power plane.

## 22.3 Decoupling Recommendations

Due to large address and data buses, and high operating frequencies, the device can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the device system, and the device itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each  $V_{DD}$ ,  $TV_{DD}$ ,  $BV_{DD}$ ,  $OV_{DD}$ ,  $GV_{DD}$ , and  $LV_{DD}$  pin of the device. These decoupling capacitors must receive their power from separate  $V_{DD}$ ,  $TV_{DD}$ ,  $BV_{DD}$ ,  $OV_{DD}$ ,  $GV_{DD}$ ,  $LV_{DD}$ , and GND power planes in the PCB, utilizing short low impedance traces to minimize inductance. Capacitors must be placed directly under the device using a standard escape pattern as much as possible. If some caps are to be placed surrounding the part it must be routed with large trace to minimize the inductance.

These capacitors must have a value of 0.1  $\mu\text{F}$ . Only ceramic SMT (surface mount technology) capacitors must be used to minimize lead inductance, preferably 0402 or 0603 sizes. Besides, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the  $V_{DD}$ ,  $TV_{DD}$ ,  $BV_{DD}$ ,  $OV_{DD}$ ,  $GV_{DD}$ , and  $LV_{DD}$  planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors must have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They must also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors—100–330  $\mu\text{F}$  (AVX TPS tantalum or Sanyo OSCON). However, customers must work directly with their power regulator vendor for best values, types and quantity of bulk capacitors.

## 22.4 SerDes Block Power Supply Decoupling Recommendations

The SerDes block requires a clean, tightly regulated source of power ( $SV_{DD}$  and  $XV_{DD}$ ) to ensure low jitter on transmit and reliable recovery of data in the receiver. An appropriate decoupling scheme is outlined below.

Only surface mount technology (SMT) capacitors must be used to minimize inductance. Connections from all capacitors to power and ground must be done with multiple vias to further reduce inductance.

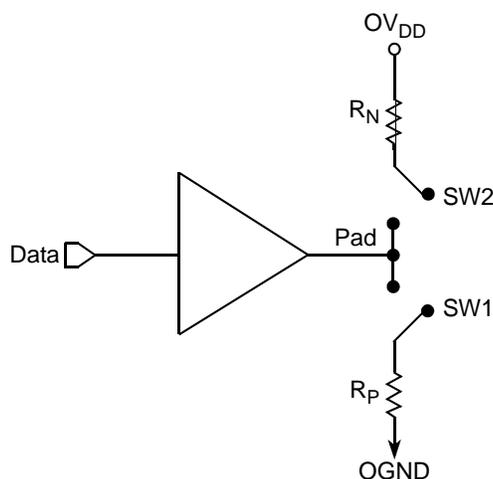


Figure 61. Driver Impedance Measurement

This table summarizes the signal impedance targets. The driver impedances are targeted at minimum  $V_{DD}$ , nominal  $OV_{DD}$ , 105°C.

Table 86. Impedance Characteristics

Impedance	Local Bus, Ethernet, DUART, Control, Configuration, Power Management	PCI	DDR DRAM	Symbol	Unit
$R_N$	43 Target	25 Target	20 Target	$Z_0$	W
$R_P$	43 Target	25 Target	20 Target	$Z_0$	W

Note: Nominal supply voltages. See Table 1,  $T_j = 105^\circ\text{C}$ .

## 22.8 Configuration Pin Muxing

The device provides the user with power-on configuration options which can be set through the use of external pull-up or pull-down resistors of 4.7 k $\Omega$  on certain output pins (see customer visible configuration pins). These pins are generally used as output only pins in normal operation.

While  $\overline{\text{HRESET}}$  is asserted however, these pins are treated as inputs. The value presented on these pins while  $\overline{\text{HRESET}}$  is asserted, is latched when  $\overline{\text{HRESET}}$  deasserts, at which time the input receiver is disabled and the I/O circuit takes on its normal function. Most of these sampled configuration pins are equipped with an on-chip gated resistor of approximately 20 k $\Omega$ . This value must permit the 4.7-k $\Omega$  resistor to pull the configuration pin to a valid logic low level. The pull-up resistor is enabled only during  $\overline{\text{HRESET}}$  (and for platform/system clocks after  $\overline{\text{HRESET}}$  deassertion to ensure capture of the reset value). When the input receiver is disabled the pull-up is also, thus allowing functional operation of the pin as an output with minimal signal quality or delay disruption. The default value for all configuration bits treated this way has been encoded such that a high voltage level puts the device into the default state and external resistors are needed only when non-default settings are required by the user.

Careful board layout with stubless connections to these pull-down resistors coupled with the large value of the pull-down resistor minimizes the disruption of signal quality or speed for output pins thus configured.

Table 87. Part Numbering Nomenclature (continued)

MPC	nnnnn	t	pp	ff	c	r
Product Code	Part Identifier	Temperature	Package <sup>1, 2, 3</sup>	Processor Frequency <sup>4</sup>	Core Frequency	Silicon Version
MPC	8545E	Blank = 0 to 105°C C = -40° to 105°C	HX = CBGA VU = Pb-free CBGA PX = PBGA VT = Pb-free PBGA	AT = 1200 AQ = 1000 AN = 800	G = 400	Blank = Ver. 2.0 (SVR = 0x80390220) A = Ver. 2.1.1 B = Ver. 2.1.2 D = Ver. 3.1.x (SVR = 0x80390231)
	8545					Blank = Ver. 2.0 (SVR = 0x80310220) A = Ver. 2.1.1 B = Ver. 2.1.2 D = Ver. 3.1.x (SVR = 0x80310231)
	8543E			AQ = 1000 AN = 800		Blank = Ver. 2.0 (SVR = 0x803A0020) A = Ver. 2.1.1 B = Ver. 2.1.2 D = Ver. 3.1.x (SVR = 0x803A0031)
	8543			Blank = Ver. 2.0 (SVR = 0x80320020) A = Ver. 2.1.1 B = Ver. 2.1.2 D = Ver. 3.1.x (SVR = 0x80320031)		

**Notes:**

1. See [Section 19, "Package Description,"](#) for more information on available package types.
2. The HiCTE FC-CBGA package is available on only Version 2.0 of the device.
3. The FC-PBGA package is available on only Version 2.1.1, 2.1.2, and 2.1.3 of the device.
4. Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by part number specifications may support other maximum core frequencies.
5. This speed available only for silicon Version 2.1.1, 2.1.2, and 2.1.3.

## 24 Document Revision History

The following table provides a revision history for this hardware specification.

**Table 88. Document Revision History**

Rev. Number	Date	Substantive Change(s)
9	02/2012	<ul style="list-style-type: none"> <li>Updated <a href="#">Section 21.2, "Thermal for Version 2.1.1, 2.1.2, and 2.1.3 Silicon FC-PBGA with Full Lid and Version 3.1.x Silicon with Stamped Lid,"</a> with version 3.0 silicon information.</li> <li>Added <a href="#">Figure 56, "Mechanical Dimensions and Bottom Surface Nomenclature of the FC-PBGA with Stamped Lid."</a></li> <li>Updated <a href="#">Table 87, "Part Numbering Nomenclature,"</a> with version 3.0 silicon information.</li> <li>Removed Note from <a href="#">Section 5.1, "Power-On Ramp Rate"</a>.</li> <li>Changed the <a href="#">Table 10</a> title to "Power Supply Ramp Rate".</li> <li>Removed table 11.</li> <li>Updated the title of <a href="#">Section 21.2, "Thermal for Version 2.1.1, 2.1.2, and 2.1.3 Silicon FC-PBGA with Full Lid and Version 3.1.x Silicon with Stamped Lid"</a> to include Thermal Version 2.1.3 and Version 3.1.x Silicon.</li> <li>Corrected the leaded Solder Ball composition in <a href="#">Table 70, "Package Parameters"</a></li> <li>Updated <a href="#">Table 87, "Part Numbering Nomenclature,"</a> with Version 3.1.x silicon information.</li> <li>Updated the Min and Max value of TDO in the valid times row of <a href="#">Table 44, "JTAG AC Timing Specifications (Independent of SYSCLK)"</a><sup>1</sup> from 4 and 25 to 2 and 10 respectively .</li> </ul>
8	04/2011	<ul style="list-style-type: none"> <li>Added <a href="#">Section 14.1, "GPOUT/GPIN Electrical Characteristics."</a></li> <li>Updated <a href="#">Table 71, "MPC8548E Pinout Listing,"</a> <a href="#">Table 72, "MPC8547E Pinout Listing,"</a> <a href="#">Table 73, "MPC8545E Pinout Listing,"</a> and <a href="#">Table 74, "MPC8543E Pinout Listing,"</a> to reflect that the TDO signal is not driven during HRSET* assertion.</li> <li>Updated <a href="#">Table 87, "Part Numbering Nomenclature"</a> with Ver. 2.1.3 silicon information.</li> </ul>
7	09/2010	<ul style="list-style-type: none"> <li>In <a href="#">Table 37, "MII Management AC Timing Specifications,</a> modified the fifth row from "MDC to MDIO delay tMDKHDX (16 × tptb_clk × 8) – 3 — (16 × tptb_clk × 8) + 3" to "MDC to MDIO delay tMDKHDX (16 × tCCB × 8) – 3 — (16 × tCCB × 8) + 3."</li> <li>Updated <a href="#">Figure 55, "Mechanical Dimensions and Bottom Surface Nomenclature of the HiCTE FC-CBGA and FC-PBGA with Full Lid</a> and figure notes.</li> </ul>
6	12/2009	<ul style="list-style-type: none"> <li>In <a href="#">Section 5.1, "Power-On Ramp Rate"</a> added explanation that Power-On Ramp Rate is required to avoid falsely triggering ESD circuitry.</li> <li>In <a href="#">Table 13</a> changed required ramp rate from 545 V/s for MVREF and VDD/XVDD/SVDD to 3500 V/s for MVREF and 4000 V/s for VDD.</li> <li>In <a href="#">Table 13</a> deleted ramp rate requirement for XVDD/SVDD.</li> <li>In <a href="#">Table 13</a> footnote 1 changed voltage range of concern from 0–400 mV to 20–500mV.</li> <li>In <a href="#">Table 13</a> added footnote 2 explaining that VDD voltage ramp rate is intended to control ramp rate of AVDD pins.</li> </ul>
5	10/2009	<ul style="list-style-type: none"> <li>In <a href="#">Table 27, "GMII Receive AC Timing Specifications,"</a> changed duty cycle specification from 40/60 to 35/75 for RX_CLK duty cycle.</li> <li>Updated tMDKHDX in <a href="#">Table 37, "MII Management AC Timing Specifications."</a></li> <li>Added a reference to Revision 2.1.2.</li> <li>Updated <a href="#">Table 55, "MII Management AC Timing Specifications."</a></li> <li>Added <a href="#">Section 5.1, "Power-On Ramp Rate."</a></li> </ul>